

**EXPEDITED PROCEDURE – EXAMINING GROUP 2823****S/N 09/484,303****PATENT****IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

Applicant: Kie Y. Ahn et al.

Examiner: William D Coleman

Serial No.: 09/484,303

Group Art Unit: 2823

Filed: January 18, 2000

Docket No.: 303.648US1

Title:

METHODS FOR MAKING INTEGRATED-CIRCUIT WIRING FROM  
COPPER, SILVER, GOLD, AND OTHER METALS**REQUEST FOR RECONSIDERATION AND EXAMINER INTERVIEW**Mail Stop AF  
Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450**RECEIVED  
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DEC 07 2004**

Further to the Notice of Appeal filed on November 10, 2004 in response to the Final Office Action of June 10, 2004, applicant submits respectfully this request and the following remarks.

**REMARKS**

Claims 5-13, 36-41 and 43-64 are now pending in this application. All the claims stand rejected under 35 USC §102 or §103, and applicant filed a Notice of Appeal of these rejections on November 10, 2004. Applicant's desire in filing this paper is to clarify issues regarding the Information Disclosure Statement filed on June 30, 2003 and to set the stage for interviewing the Examiner regarding his view of Mikagi, the principle reference underpinning the rejections.

**Information Disclosure Statement**

Applicant submits respectfully that a Supplemental Information Disclosure Statement (SIDS) and accompanying 1449 Form were filed on June 30, 2003, along with copies of 68 references. However, in the Advisory Action, the Examiner asserted that the SIDS was not proper because it lacked a statement as specified in 37 CFR 1.97(e) and thus has not been considered. Moreover, the Examiner stated that applicant "should direct the Examiner as to the location of the signature and date line as required on the PTO-1449."

In response, applicant submits respectfully that the SIDS was filed on June 30, 2003 along with the required fee and a response to the non-final Office Action of March 31, 2003. (See the attached copy of the stamped, return post card.) As such, no statement under 1.97(e) was

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